

Fig. 2. The view of the sealing plug setting.

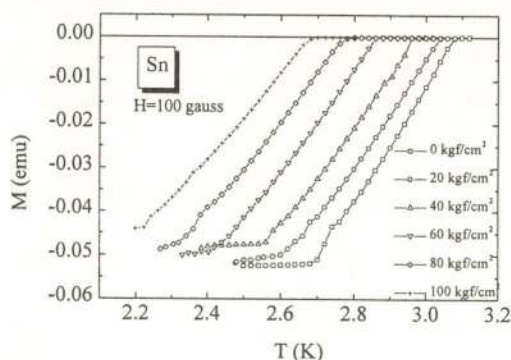


Fig. 3. Temperature dependent susceptibility of Sn for several applied forces normalized by the inner, high-pressure area of the micro cell.

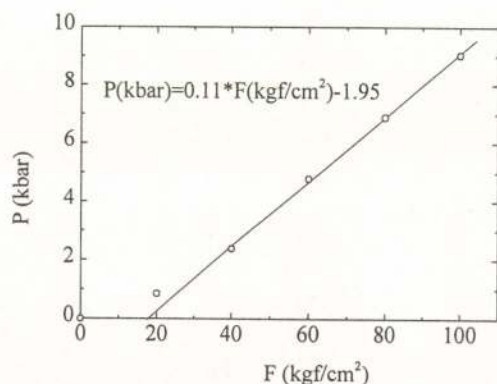


Fig. 4. Pressure at about $T=3$ K versus applied pressure at room temperature

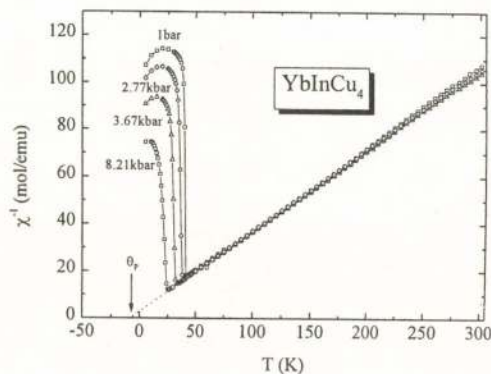


Fig. 5. $\chi^{-1}(T)$ plotted versus temperature at various pressures applied to single crystal YbInCu_4 .

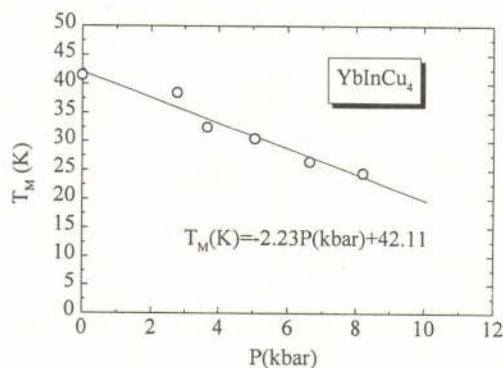


Fig. 6. Valence fluctuation transition temperature in YbInCu_4 versus pressure.

3. Magnetic Measurements of YbInCu_4

The intermetallic compound YbInCu_4 exhibits the well-known sharp phase transition around $T=40$ K due to a valence transition fluctuation of the Yb ion. Fig 5 shows $\chi^{-1}(T)$ plotted versus temperature for a single crystal of YbInCu_4 at various pressures. At 1 bar, the temperature dependence of the susceptibility is identical to previous results [7], within experimental error. The sharp rise at $T=40$ K ($P=1$ bar), due to the Yb valence change with increasing temperature decreases with increasing pressure at the rate of $dT_M/dP=-2.23$ K/kbar, which is slightly larger than previously reported [8]. This

